
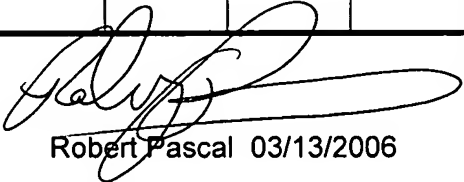


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/805,297	WANG ET AL.	
	Examiner	Art Unit	
	Hieu P. Nguyen	2817	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
330		282			330	86			
INTERNATIONAL CLASSIFICATION									
H	0	3	F	3/30					
				/					
				/					
				/					
				/					

Hieu Nguyen 03/13/2006 (Assistant Examiner) (Date)		 Robert Pascal 03/13/2006 (Primary Examiner) (Date)	Total Claims Allowed: 17	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 4

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA					<input type="checkbox"/> T.D.					<input type="checkbox"/> R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original			
	1			31			61			121			151			181			
	2			32			62			122			152			182			
	3			33			63			123			153			183			
	4			34			64			124			154			184			
1	5			35			65			125			155			185			
2	6			36			66			126			156			186			
3	7			37			67			127			157			187			
4	8			38			68			128			158			188			
5	9			39			69			129			159			189			
6	10			40			70			130			160			190			
7	11			41			71			131			161			191			
	12			42			72			132			162			192			
8	13			43			73			133			163			193			
9	14			44			74			134			164			194			
10	15			45			75			135			165			195			
11	16			46			76			136			166			196			
12	17			47			77			137			167			197			
13	18			48			78			138			168			198			
14	19			49			79			139			169			199			
15	20			50			80			140			170			200			
16	21			51			81			141			171			201			
17	22			52			82			142			172			202			
	23			53			83			143			173			203			
	24			54			84			144			174			204			
	25			55			85			145			175			205			
	26			56			86			146			176			206			
	27			57			87			147			177			207			
	28			58			88			148			178			208			
	29			59			89			149			179			209			
	30			60			90			150			180			210			